

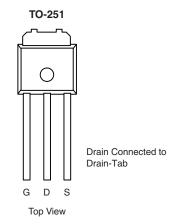
# N-Channel 100-V (D-S) MOSFET

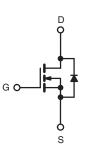
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	100			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.20			
Q <sub>g</sub> (Max.) (nC)	16			
Q <sub>gs</sub> (nC)	4.4			
Q <sub>gd</sub> (nC)	7.7			
Configuration	Single			

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (7	√ <sub>C</sub> = 25 °C, un	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	100	V	
Gate-Source Voltage			$V_{GS}$	± 20	V	
Continuous Drain Current	V at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$	1	12		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	7.5	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	37		
Linear Derating Factor				0.40	W/°C	
Linear Derating Factor (PCB Mount)				0.025	VV/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	200	mJ	
Avalanche Currenta			I <sub>AR</sub>	9.2	Α	
Repetitive Avalanche Energya			E <sub>AR</sub>	6.0	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$		P <sub>D</sub>	60	W		
Maximum Power Dissipation (PCB Mount) T <sub>A</sub> = 25 °C			3.7	]		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	1 00	
Soldering Recommendations (Peak Temperature) For 10 s				300 <sup>d</sup>	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=25$  V, starting  $T_J=25$  °C, L=3.5 mH,  $R_q=25$   $\Omega$ ,  $I_{AS}=9.2$  A (see fig. 12). c.  $I_{SD}\leq 9.2$  A,  $dI/dt\leq 110$  A/µs,  $V_{DD}\leq V_{DS}$ ,  $T_J\leq 175$  °C.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62	
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	2.5	

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		•		,			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$ , $I_D = 250 \mu A$		100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1.0	-	3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zana Oala Wallana Baria Oana d		V <sub>DS</sub> =	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80 V	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 5.5 A <sup>b</sup>	-	0.20	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 5.5 A <sup>b</sup>	2.7	-	-	S
Dynamic		•		,			
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	360	-	
Output Capacitance	C <sub>oss</sub>	1	$V_{DS} = 25 V$ ,	-	150	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	0 MHz, see fig. 5	-	34	-	
Total Gate Charge	Qg			-	-	16	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 9.2 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	4.4	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	See fig. 6 and 16	-	-	7.7	
Turn-On Delay Time	t <sub>d(on)</sub>			-	8.8	-	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> =	= 50 V, I <sub>D</sub> = 9.2 A,	-	30	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{\rm g} = 18 \Omega,  R_{\rm D} = 5.2 \Omega,  {\rm see  fig.  10^b}$		-	ns		
Fall Time	t <sub>f</sub>	1		-	20	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from		-	4.5	-	-11
Internal Source Inductance	L <sub>S</sub>	package and die cont		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET s showing	the	-	-	9.2	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	37	A
Body Diode Voltage	V <sub>SD</sub>	$T_{J} = 25  ^{\circ}\text{C},  I_{S} = 9.2  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 ^{\circ}\text{C},  I_F = 9.2  \text{A},  \text{dl/dt} = 100  \text{A/}\mu\text{s}^b$ $         -$		ns			
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			1.3	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s$ ; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

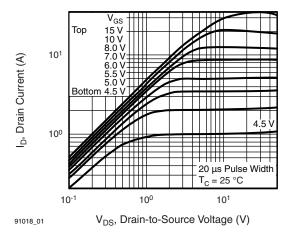


Fig. 1 - Typical Output Characteristics,  $T_C = 25$  °C

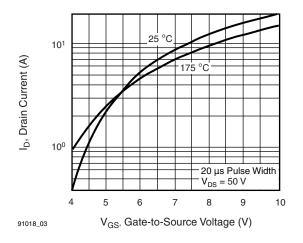


Fig. 3 - Typical Transfer Characteristics

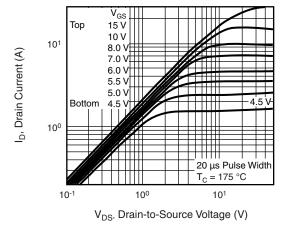


Fig. 2 - Typical Output Characteristics,  $T_C$  = 175  $^{\circ}C$ 

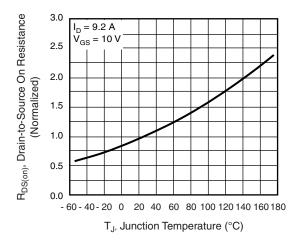
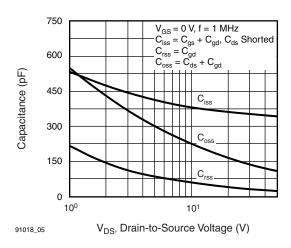
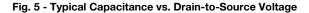


Fig. 4 - Normalized On-Resistance vs. Temperature







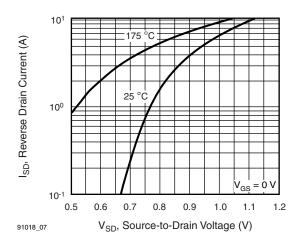


Fig. 7 - Typical Source-Drain Diode Forward Voltage

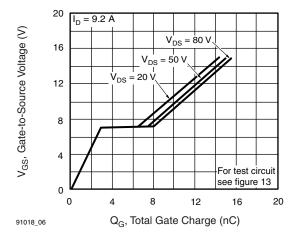


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

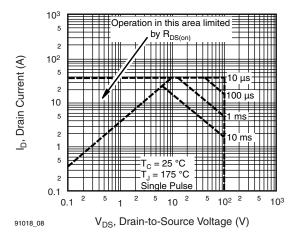


Fig. 8 - Maximum Safe Operating Area



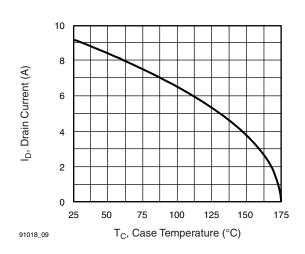


Fig. 9 - Maximum Drain Current vs. Case Temperature

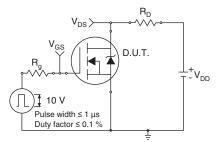


Fig. 10a - Switching Time Test Circuit

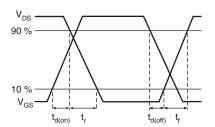


Fig. 10b - Switching Time Waveforms

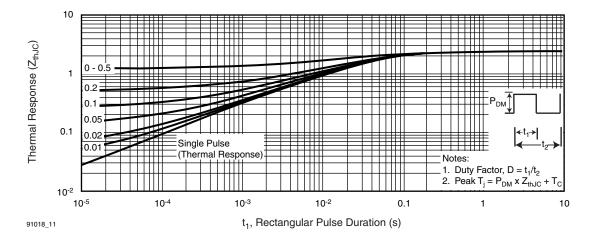


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



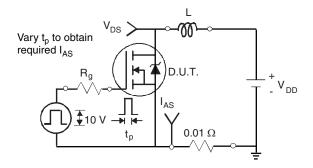


Fig. 12a - Unclamped Inductive Test Circuit

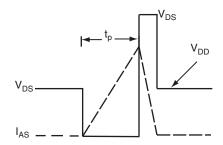


Fig. 12b - Unclamped Inductive Waveforms

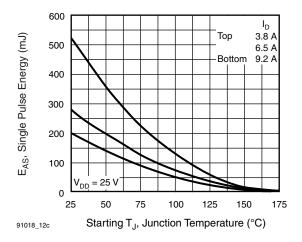


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

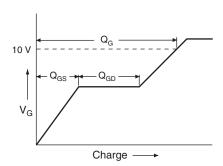


Fig. 13a - Basic Gate Charge Waveform

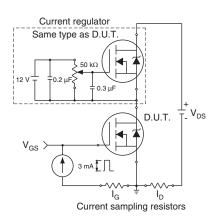
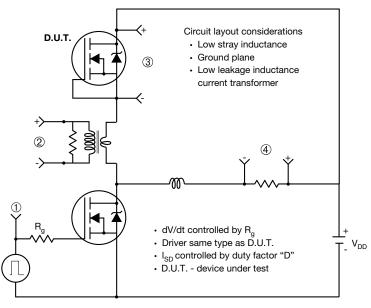


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



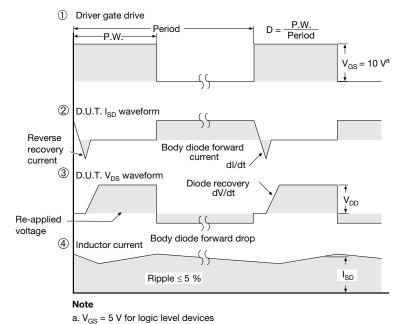
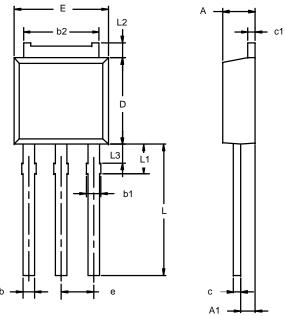


Fig. 14 - For N-Channel



### TO-251AA



	A1	1
Note:	Dimension I 3 is for reference only	

	MILLIM	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28	BSC	0.090	BSC	
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	



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